

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10791924	BRUNN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Lee, Siu M	2611

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	232, 229, 346, 254, 242, 241	5/31/2007	Siu M. Lee

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	6/6/2007	Siu M. Lee
Discuss the application with Chieh Fan	6/6/2007	Siu M. Lee
EAST	11/21/2007	Siu M. Lee
Discuss the amendment with Chieh Fan	11/21/2007	Siu M. Lee
EAST	5/1/2008	Siu M. Lee
Discuss teh application with Chieh Fan	5/1/2008	Siu M. Lee
EAST	11/4/2008	Siu M. Lee
Discuss the amendment with Chieh Fan	10/31/2008	Siu M. Lee

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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